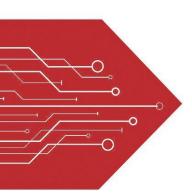
# MSKSEMI















**ESD** 

**TVS** 

**TSS** 

MOV

**GDT** 

**PLED** 

Broduct data speet



# P-Channel Enhancement Mode Power MOSFET

## **General Features**

 $V_{DS} = -30V, I_{D} = -4.1A$ 

 $R_{DS(ON)}$  < 95m $\Omega$  @  $V_{GS}$ =-4.5V

 $R_{DS(ON)}$  < 65m $\Omega$  @  $V_{GS}$ =-10V

High power and current handing capability

Lead free product is acquired

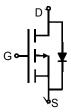
Surface mount package

## **Application**

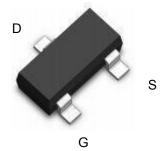
PWM applications

Load switch

Power management



Schematic diagram



### Absolute Maximum Ratings (T<sub>A</sub>=25 ℃unless otherwise noted)

| Parameter  | Symbol           | Limit      | Unit |
|--|------------------|------------|------|
| Drain-Source Voltage                             | V <sub>DS</sub>  | -30        | V    |
| Gate-Source Voltage                              | V <sub>GS</sub>  | ±20        | V    |
| Drain Current-Continuous                         | I <sub>D</sub>   | -4.1       | А    |
| Drain Current-Pulsed (Note 1)                    | I <sub>DM</sub>  | -20        | Α    |
| Maximum Power Dissipation                        | P <sub>D</sub>   | 1.4        | W    |
| Operating Junction and Storage Temperature Range | $T_{J}, T_{STG}$ | -55 To 150 | °C   |

#### **Thermal Characteristic**

| Thermal Resistance, Junction-to-Ambient (Note 2) | Reja | 90 | °C/W |
|--|------|----|------|
|--|------|----|------|

## Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

| Parameter                       | Symbol            | Condition                                  | Min | Тур | Max | Unit |
|---------------------------------|-------------------|--|-----|-----|-----|------|
| Off Characteristics             |                   |  |     |     |     |      |
| Drain-Source Breakdown Voltage  | BV <sub>DSS</sub> | V <sub>GS</sub> =0V I <sub>D</sub> =-250μA | -30 | -33 | -   | V    |
| Zero Gate Voltage Drain Current | I <sub>DSS</sub>  | V <sub>DS</sub> =-24V,V <sub>GS</sub> =0V  | -   | -   | -1  | μA   |





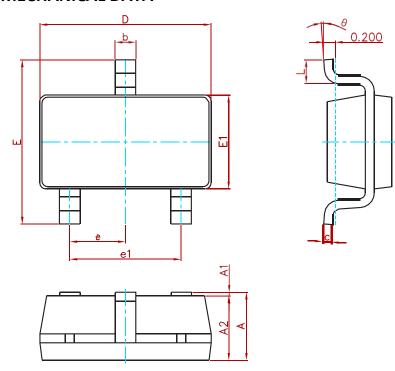
| Parameter                          | Symbol              | Condition   | Min | Тур  | Max  | Unit |
|------------------------------------|---------------------|---|-----|------|------|------|
| Gate-Body Leakage Current          | I <sub>GSS</sub>    | V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V                       | -   | -    | ±100 | nA   |
| On Characteristics (Note 3)        |                     |   |     |      |      |      |
| Gate Threshold Voltage             | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA        | -1  | -1.5 | -3   | V    |
| Building Control Building          | R <sub>DS(ON)</sub> | V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.1A                    | -   | 48   | 65   | mΩ   |
| Drain-Source On-State Resistance   |                     | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A                     | -   | 60   | 95   | mΩ   |
| Forward Transconductance           | <b>g</b> FS         | V <sub>DS</sub> =-5V,I <sub>D</sub> =-4.1A                      | 5.5 | -    | -    | S    |
| Dynamic Characteristics (Note4)    |                     |   | •   |      |      |      |
| Input Capacitance                  | C <sub>lss</sub>    | \/ 45\/\/ O\/   | -   | 650  | -    | PF   |
| Output Capacitance                 | Coss                | V <sub>DS</sub> =-15V,V <sub>GS</sub> =0V,<br>F=1.0MHz          | -   | 105  | -    | PF   |
| Reverse Transfer Capacitance       | Crss                | F=1.0WHZ  | -   | 65   | -    | PF   |
| Switching Characteristics (Note 4) |                     |   | •   |      |      |      |
| Turn-on Delay Time                 | t <sub>d(on)</sub>  |   | -   | 8.5  | -    | nS   |
| Turn-on Rise Time                  | t <sub>r</sub>      | V <sub>DD</sub> =-15V,R <sub>L</sub> =3.6Ω                      | -   | 4.5  | -    | nS   |
| Turn-Off Delay Time                | t <sub>d(off)</sub> | $V_{GS}$ =-10V, $R_{GEN}$ =3 $\Omega$                           | -   | 26   | -    | nS   |
| Turn-Off Fall Time                 | tf                  |   | -   | 12.5 | -    | nS   |
| Total Gate Charge                  | Qg                  |   | -   | 12.5 | -    | nC   |
| Gate-Source Charge                 | Q <sub>gs</sub>     | V <sub>DS</sub> =-15V,I <sub>D</sub> =-4A,V <sub>GS</sub> =-10V | -   | 2.8  | -    | nC   |
| Gate-Drain Charge                  | Q <sub>gd</sub>     |   | -   | 2.7  | -    | nC   |
| Drain-Source Diode Characteristics |                     |   |     |      |      |      |
| Diode Forward Voltage (Note 3)     | V <sub>SD</sub>     | V <sub>GS</sub> =0V,I <sub>S</sub> =-4.1A                       | -   | -    | -1.2 | V    |

#### Notes:

- **1.** Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- **3.** Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

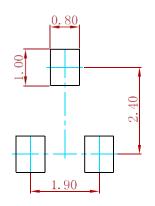


# **PACKAGE MECHANICAL DATA**



| Symbol | Dimensions In Millimeters |       | Dimension | s In Inches |
|--------|---------------------------|-------|-----------|-------------|
| Symbol | Min.                      | Max.  | Min.      | Max.        |
| Α      | 1.050                     | 1.250 | 0.041     | 0.049       |
| A1     | 0.000                     | 0.100 | 0.000     | 0.004       |
| A2     | 1.050                     | 1.150 | 0.041     | 0.045       |
| b      | 0.300                     | 0.500 | 0.012     | 0.020       |
| С      | 0.100                     | 0.200 | 0.004     | 0.008       |
| D      | 2.820                     | 3.020 | 0.111     | 0.119       |
| E1     | 1.500                     | 1.700 | 0.059     | 0.067       |
| E      | 2.650                     | 2.950 | 0.104     | 0.116       |
| е      | 0.950(BSC)                |       | 0.037     | (BSC)       |
| e1     | 1.800                     | 2.000 | 0.071     | 0.079       |
| L      | 0.300                     | 0.600 | 0.012     | 0.024       |
| 0      | 0°                        | 8°    | 0°        | 8°          |

# **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

# **REEL SPECIFICATION**

| P/N        | PKG    | QTY  |
|------------|--------|------|
| WPM3407-MS | SOT-23 | 3000 |









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